

### OPERATION AND SERVICE MANUAL

# MODEL 510L LINECHEK™

## LINE LEAKAGE TESTER

#### WITH IEEE-488 (GPIB) OR RS-232 INTERFACE

#### SERIAL NUMBER

# Model 510L

ltem 37977

Ver 1.19

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Model 510L		
<b>Functional Specifications</b>		

510L INPUT						
Voltage	$115/230$ VAC $\pm 15\%$ ,	Single Phase, User selection				
Frequency	50/60 Hz ± 5%,					
Fuse	2 A 250 V Slo-Blo					
DUT POWER	DUT POWER					
Voltage	30 - 300 VAC Single Phase Unbalanced					
	(One Hot or Line conductor and One Neutral)					
Current	30 AAC max continuous					
Voltage Display	Range:	30.0 - 300.0 VAC Full Scale				
	Resolution:	0.1 V				
	Accuracy:	$\pm (1\% \text{ of reading} + 0.2 \text{ V})$				
Short Circuit Protection	32 AAC, Response Time < 600 ms					
LEAKAGE CURRENT						
Current Display	Range 1:	0.0 μΑ - 999.9 μΑ				
True RMS Responding	Resolution:	0.1 μA/step				
	Range 2:	1000 μΑ - 6000 μΑ				
	Resolution:	1 μA/step				
	Accuracy:					
	DC to 100 kHz	$\pm$ (1.5% of reading + 3 counts)				
	>100 kHz to 1 MHz	$\pm5\%$ of reading, (10.0 $\mu A-6000\;\mu A)$				
Measuring Device	А	UL 544 Non Patient				
	В	UL 544 Patient				
	С	IEC 601-1, UL 2601, EN 60601-1				
	D	UL 1563				
	Е	IEC 1010, UL 3101, IEC 950, UL 1950				
MD A - D components	Accuracy:	Resistance $\pm 1\%$ Capacitance $\pm 5\%$				
MD E components	Accuracy:	Resistance $\pm 0.1\%$ Capacitance $\pm 1\%$				
MD Voltage Limit	Maximum 20 V peak or 20 VDC					



HI-I imit / I O-I imit	Range	$0 = 6000 \text{ m} \Delta (0 - \text{Off})$		
	Range.	$0 - 0000  \mu A  (0 - 01)$		
	Resolution:	1 μΑ		
	Accuracy:	Same as Leakage Current Display		
		Accuracy		
Delay Timer	Range:	$0, 1.0 - 999.9 \text{ sec} \ (0 = \text{Constant})$		
	Resolution:	0.1 sec/step		
	Accuracy:	$\pm (0.1\% + 0.1 \text{ sec})$		
GENERAL SPECIFICATIONS				
PLC Remote Control	Input - Test, Reset, Execute memory # 1, # 2 and # 3			
	Output - Pass, Fail, Test-in-Process, and Reset			
Memory	Allows storage of up to 10 groups of different test			
	programs and 8 st	ep/each memory.		
Security	Programmable password lockout capability to avoid			
	unauthorized acce	ss to test set-up program.		
LCD Contrast Setting	9 ranges set by the numeric keys on the front panel.			
Buzzer Volume Setting	10 ranges set by the numeric keys on the front panel.			
Calibration	Software and adjustments are made through front panel.			
Mechanical	Bench or rack mount with tilt up front feet.			
Dimension	(W x H x D) 17 x 4 x 16.5 in. (432 x 102 x 419 mm)			
Weight	15.9 lbs (7.2 Kgs)			



#### **KEY FEATURES & BENEFITS SUMMARY: MODEL 510L**

FEATURES	BENEFITS
Provides 8 of the most common safety	No need to manually set up the test or to switch test
tests	leads around.
The 5 most common measuring	A versatile tester that can be set-up to meet multiple
devices are built-in and can be	specifications without the need for complicated
selected through software control	external connections, or the need for separate
	instruments.
Fully complies with the latest	Complies with the latest EN such as the Low
European Norms	Voltage Directive and Medical Directive.
Programmable security password	Avoids tampering with settings by only allowing
system	authorized personnel with a user programmable
	security password to change test parameters.
Front panel calibration	All calibration is done through a simple user
	interface from the front panel. No need to open the
	instrument.
PLC, RS-232 or GPIB Control	Provides flexibility for semi-automatic or automatic
	operation with a choice of communication protocols
	which provides the capability for easy test data
	storage.
Microprocessor control with software	Microprocessor control allows for many advanced
menuing	features such as automatic testing, memories and
	software control.
External measurement circuit	One external measurement circuit is provided for
	measurement of other devices.
Separate current trip points for each	Each test can have a separate trip point for failure
test	analysis.
50 Memories for test storage	Storage of test set-ups so parameters only need to
	be entered once then memorized.
Complete with software driver	National Instruments LabVIEW® software driver is
	provided for automated applications to ease the
	testing process.
Ranges from DC to 1 MHz	Complies with even the 1 MHz specification for
	IEC testing.